

INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)				ATTY DOCKET NO.	SERIAL NO.		
				ITL.0725D1US (P14251D)		10/643,427	
				APPLICANT(S):	Qing Ma et al.		
				FILING DATE:	August 19, 2003		
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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KR	G.	EP 0 994 330 A1	04/19/2000	EPO			
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	J.						
	K.						
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EXAMINER	<i>[Signature]</i>			DATE CONSIDERED		10/7/04	
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